

Substitute Form PTO-1449 (Modified) Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 09215-011001	Application No. 10/783,846
	Applicant Yuen-Foo Michael Kou		
	Filing Date February 20, 2004	Group Art Unit 2829	

U.S. Patent Documents

Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
J. m. H.	AA	4,728,885	03/01/1988	DeSanto			
	AB	4,684,884	08/04/1987	Soderlund			
	AC	5,764,073	06/09/1998	Sadamatsu			
	AD	6,560,839	05/13/2003	Tow			
	AE	4,242,632	12/30/1980	Irvin			
	AF	4,426,619	01/17/1984	Demand			
	AG	4,939,469	07/03/1990	Ludwig et al.			
	AH	5,024,532	06/18/1991	Rall			
	AI	5,434,737	07/18/1995	Miura			
	AJ	5,450,018	09/12/1995	Rieser et al.			
	AK	5,606,264	02/25/1997	Licari et al.			
	AL	5,867,809	02/02/1999	Soga et al.			
	AM	6,113,262	09/05/2000	Purolo et al.			
	AN	US 2003/0102367	06/05/2003	Monette et al.			

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation
J. m. H.	AO	JP 61-068514	04/08/1986	Japan			<input checked="" type="checkbox"/> Yes <input type="checkbox"/> No
	AP	JP 06042986	02/18/1994	Japan			Abstract

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
J. m. H.	AQ	"Cytherm Temperature Data Logger Key", Dynasys Technologies Inc., Spring 2000
	AR	"DALLAS Semiconductor, DS2438 Smart Battery Monitor", www.dalsemi.com, 04/10/01, pp 1-29.
	AS	"Humidity Sensors Relative Humidity", Honeywell HIH Series, pp 99, 100., 2000
	AT	"Joint Industry Standard", IPC/JEDEC J-STD-033, April 1999.
	AU	"Microchip PIC12C67X", © 1999 Microchip Technology Inc., 9 m. H.
	AV	Awtrey et al., "A1-Wire Humidity Sensor", Sensors The Journal of Applied Sensing Technology,

August 2000

Examiner Signature <i>J. m. H.</i>	Date Considered 6/24/05
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	